

# 802.3cw D1.4 Comments #30-#39

## Interoperable Transmitter Metrics

Author - Mike A. Sluyski

Cisco Systems Inc.

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# Supporters:

Gary Nicholls – Cisco Systems Inc.

Mark Nowell – Cisco Systems Inc.

Tom Williams – Cisco Systems Inc.

Jeff Maki – Juniper

Charles Park - Juniper

Massimo Sorbana – Global Foundries

Winston Way - Neo Photonics

Binbin Guan – Microsoft

Yawei Yin – Microsoft

Tetsuyuki Suzaki – NEC

Kumi Omori - NEC

# Observations

- No single metric can fully qualify a Transmitter as being compliant to the 400GBASE-ZR specification, nor determine its ability to interoperate with another vendor's modules.
- In October 2021 the 802.3cw TF passed a motion adopting EVM Measurement Methodology for correlation for EVM TQM.  
[https://www.ieee802.org/3/cw/tools/EVMTQM\\_211025.pdf](https://www.ieee802.org/3/cw/tools/EVMTQM_211025.pdf)
  - For this methodology, it is assumed that the DUT DP-16QAM Transmitter and the DP-16QAM Receiver are from the same implementer.
    - Requires Module vendor access to skew TX parameters independently.
  - For this methodology an EVM reference Rx is defined.
  - Test Objective is to provide correlation between the transmitter's EVM to ROSNR penalty.
  - i.e., Transmitter EVM measured by a well-defined constellation analyzer correlates with measured ROSNR
- EVM's expected results
  - Converge multiple TX spectral parameters into a single measurement for TX Spectral quality. EVM(max) threshold for guaranteed Interoperability.
  - Ability for manufacturer to trade-off TX parameters for maximum yield/lowest cost.
  - Identify TX parameters that are required to be independently specified. These parameters would need to be compensated by RX or Limited at TX.
  - All non-EVM parameters would be independently verified.

# Current State

- EVM Status – Not qualified as a TX spectral Quality metric for 400G DP-16QAM- Limited test results submitted to date

[https://www.ieee802.org/3/ct/public/19\\_03/anslow\\_3ct\\_02\\_0319.pdf](https://www.ieee802.org/3/ct/public/19_03/anslow_3ct_02_0319.pdf)

[https://www.ieee802.org/3/ct/public/19\\_07/pittala\\_3ct\\_01a\\_0719.pdf](https://www.ieee802.org/3/ct/public/19_07/pittala_3ct_01a_0719.pdf)

[https://www.ieee802.org/3/cw/public/adhoc/22\\_0223/rahn\\_3cw\\_01a\\_220223.pdf](https://www.ieee802.org/3/cw/public/adhoc/22_0223/rahn_3cw_01a_220223.pdf)

- ROSNR values show little correlation with EVM

[https://www.ieee802.org/3/cw/public/22\\_03/maniloff\\_3cw\\_01\\_220314.pdf](https://www.ieee802.org/3/cw/public/22_03/maniloff_3cw_01_220314.pdf)

- EVM measurements are performed unloaded
- Required OSNR was determined using ASE noise loading
- RX compensation loops intentionally disabled to measure impact of TX impairments on ROSNR.

Maniloff\_3cw\_01\_220314 does demonstrate:

- The impact of each impairment on EVM.
- I/Q Skew, I/Q imbalance, and Quadrature Error result in performance penalties vs Tx EVM, similar to AWGN.
  - RX OSNR penalty based on these TX values may vary by receiver
  - Correlation of EVM to ROSNR may not be feasible - Unless it is the well defined reference receiver.

Crux of EVM as a TX Quality Metric is that the ROSNR performance is still a combination of the TX/RX performance. Vendor to vendor performance will vary. As a result, where do you define the limit?

# TQM proposal:

1. Goal of P802.3cw is to define a multi-vendor interoperable specification.
2. Currently, the lack of EVM qualification as a TQM is limiting P802.3cw progress
3. Other Standards Organizations that have specified and released 400G 16QAM specifications with demonstrated interoperability by:
  - Taking a parametric approach - Fully specifying ALL Tx parameters.
  - Identifying a common set(s) of Test vectors and test methodologies.
  - Private and Independent verification of the specified parameters have occurred.
  - Public multi-vendor interop demonstrations – e.g., OFC
4. Benefits include:
  - Completely specified TX. No ambiguity on parameters required for interoperability.
5. EVM qualification can proceed in parallel.
  - EVM remains a promising approach that would allow a TQM to be measured while allowing greater design flexibility.
  - Eventual Realization of EVM as a TX quality Metric, along with its benefits and goals.

# Recommendation:

- Progress the 802.3cw specification by fully specifying the TX as outlined in this presentation.
  - This proposal removes EVM methodology as a hurdle to progressing the 802.3cw draft.
  - Adoption of this proposal may accelerate EVM definition by fully defining TX parameters.
- Include clear TX Metric definitions and Test Methodologies for the following TX parameters:
  - TX Clock Phase Noise – (See 802d3cw\_D1.4 review comment #30-33 and details on pgs. 7-10).
  - Specify I/Q parameters – (See 802.3cw\_D1.4 review comments #34-37 and details on pg. 11)
- Recommendation: Adopt TX parameters specified on pgs. 8-11.
- Maintain EVM test and measurement methodology in 802.3cw as informational/directional.
  - Adoption of EVM remains possible at a later stage with more contributions and consensus building.

# Comment #30: Error Vector Magnitude

**Remove from Table 156-6 400GBASE-ZR transmit characteristics: Error Vector Magnitude (max)**

|                              |     |   |
|------------------------------|-----|---|
| Error vector magnitude (max) | TBD | % |
|------------------------------|-----|---|

**Alternative to removal - Table 156-6 400GBASE-ZR transmit characteristics: Error Vector Magnitude (max)**

|   |                                 |   |
|---|---------------------------------|---|
| Error vector magnitude (max) <sup>1</sup> | <under study><br>(See 156.9.10) | % |
|---|---------------------------------|---|

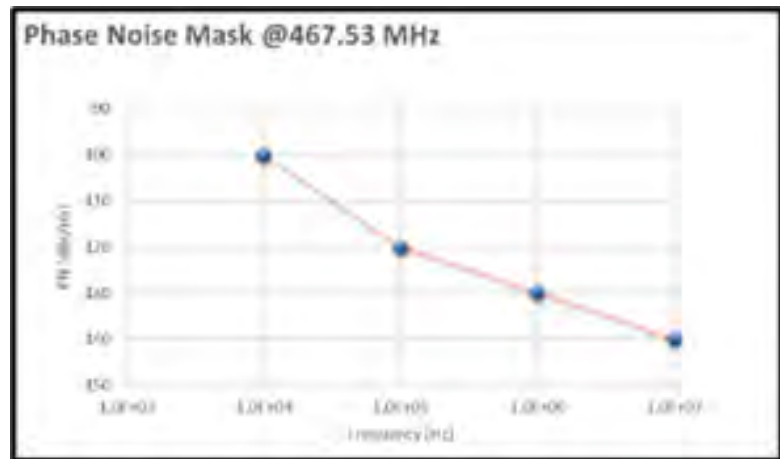
<sup>1</sup>Error Vector Magnitude (max) is an informative Tx quality metric that is under study for future consideration. EVM is not a requirement for compliance.

# Comment #31: TX Clock Phase Noise

**Add to Table 156-6 400GBASE-ZR transmit characteristics:** Tx Clock Phase Noise – Maximum PN mask

|  |          |        |
|--|----------|--------|
| Tx Clock Phase Noise - Maximum PN mask | See mask | dBc/Hz |
|--|----------|--------|

**Add Mask and definition to 156.9.x:** Tx Clock Phase Noise – Maximum PN mask



| PN [dBc/Hz] | Frequency [Hz] |
|-------------|----------------|
| -100        | 1.00E+04       |
| -120        | 1.00E+05       |
| -130        | 1.00E+06       |
| -140        | 1.00E+07       |

Phase noise,  $\mathcal{L}(f)$ ,  $f_c = \frac{f_{\text{baud}}}{128} = \sim 467.53 \text{ MHz}$  Mask does not apply to spurs, broadband phase noise only. Spurs are considered separately.



# Comment #32: TX Clock Phase Noise (cont.)

**Add to Table 156-6 400GBASE-ZR transmit characteristics:** TX Clock Phase Noise – Maximum Total Integrated RMS phase jitter between 10Khz and 10 MHz

|  |     |    |
|--|-----|----|
| TX Clock Phase Noise- Total Integrated RMS phase jitter between 10KHz and 10 MHz (max) | 600 | fs |
|--|-----|----|

**Add Definition to 156.9.x:** TX Clock Phase Noise – Maximum Total Integrated RMS phase jitter between 10Khz and 10 MHz:

$$\text{rms random jitter: } \sigma_{rj} = \frac{1}{2\pi f_c} \sqrt{2 \cdot \int_{f_1}^{f_2} 10^{\frac{\mathcal{L}(f)}{10}} df} \quad \text{rms periodic jitter (spurs): } \sigma_{pj,i} = \frac{1}{\sqrt{2}\pi f_c} \cdot 10^{\frac{s_i}{20}}$$

where,  $f_1 = 10\text{kHz}$ ,  $f_2 = 10\text{MHz}$ ,  $f_c = \frac{f_{\text{baud}}}{128} = \sim 467.53\text{MHz}$ ,  $\mathcal{L}(f) = \text{phase noise (PN)}$ ,

$$s_i = \text{individual spur in [dBc]} \quad \text{rms total jitter: } \sigma_{tj} = \sqrt{\sigma_{rj}^2 + \sum_{i=1}^N \sigma_{pj,i}^2}$$

where, N = total number of spurs.

# Comment #33: TX Clock Phase Noise (cont.)

**Add to Table 156-6 400GBASE-ZR transmit characteristics:** TX Clock Phase Noise – Maximum Total Integrated RMS phase jitter between 1MHz and 200MHz

|   |     |    |
|---|-----|----|
| TX Clock Phase Noise- Total Integrated RMS phase jitter between 1MHz and 200 MHz (max). | 250 | fs |
|---|-----|----|

**Add Definition to 156.9.x:** TX Clock Phase Noise – Maximum Total Integrated RMS phase jitter between 1MHz and 200MHz.

$$\text{rms random jitter: } \sigma_{rj} = \frac{1}{2\pi f_c} \sqrt{2 \cdot \int_{f_1}^{f_2} 10^{\frac{\mathcal{L}(f)}{10}} df}$$

$$\text{rms periodic jitter (spurs): } \sigma_{pj,i} = \frac{1}{\sqrt{2}\pi f_c} \cdot 10^{\frac{s_i}{20}}$$

where,  $f_1 = 1\text{MHz}$ ,  $f_2 = 200\text{MHz}$ ,  $f_c = \frac{f_{\text{baud}}}{128} = 467.53\text{MHz}$ ,  $\mathcal{L}(f) = \text{phase noise (PN)}$ ,  $s_i = \text{individual spur in [dBc]}$

$$\text{rms total jitter: } \sigma_{tj} = \sqrt{\sigma_{rj}^2 + \sum_{i=1}^N \sigma_{pj,i}^2}$$

where, N = total number of spurs.

# Comments # 34-37 I/Q Parameters

**Add to Table 156-6 400GBASE-ZR transmit characteristics:**

|                                |      |     |
|--------------------------------|------|-----|
| I/Q Phase error (min)          | -5   | deg |
| I/Q Phase error (min)          | +5   | deg |
| I/Q Quadrature Skew (max)      | 0.75 | ps  |
| I/Q Amplitude Imbalance (mean) | 1    | dB  |

**Add Definitions to 156.9.x:**

I/Q Phase error – The difference in phase of a measured I/Q signal and a reference IQ signal. E.g., as determined by a VSA

I/Q Quadrature skew –

I/Q Amplitude Imbalance – To be added